

MRI200.17

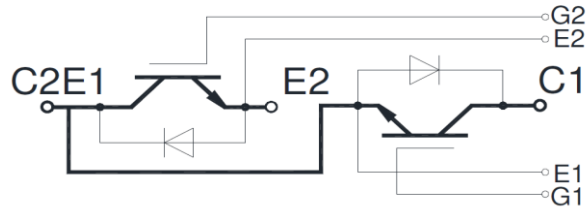
2 in 1 IGBT Modules

Features:

- Low $V_{CE(sat)}$ trench IGBT technology
- Low switching losses
- $V_{CE(sat)}$ with positive temperature coefficient
- 10 μ s short circuit capability

Typical applications:

- AC motor control
- Inverter and power supplies
- Motion/servo control
- Photovoltaic/Fuel cell



Symbol	Characteristics	Test Conditions	Value			Unit	
			Min	Typ	Max		
V_{CES}	Collector-Emitter voltage	$T_j = 25^\circ\text{C}$			1700	V	
V_{GES}	Gate-Emitter voltage	$T_j = 25^\circ\text{C}$			± 20	V	
I_C	Collector current	Continuous @ $T_c = 80^\circ\text{C}$, $T_{jmax} = 175^\circ\text{C}$			200	A	
I_{CM}	Repetitive peak collector current	$T_p = 1\text{ ms}$			400	A	
P_C	Collector power dissipation	$T_j = 175^\circ\text{C}$, 1 device			1515	W	
T_j	Junction temperature	/	-40		175	$^\circ\text{C}$	
T_{stg}	Storage temperature	/	-40		125	$^\circ\text{C}$	
V_{ISO}	Isolation between terminal and copper base	$T_j = 25^\circ\text{C}$, AC: 1 minute	4000			V	
Screw torque	Mounting (M6)	/	3.0		5.0	N·m	
	Terminals (M6)	/	2.5		5.0	N·m	
I_{CES}	Zero gate voltage collector current	$T_j = 25^\circ\text{C}$, $V_{CE} = V_{CES}$, $V_{GE} = 0\text{V}$			3.0	mA	
I_{GES}	Gate-Emitter leakage current	$T_j = 25^\circ\text{C}$, $V_{CE} = 0\text{V}$, $V_{GE} = \pm 20\text{V}$			± 0.4	μA	
$V_{GE(th)}$	Gate-Emitter threshold voltage	$T_j = 25^\circ\text{C}$, $V_{CE} = 20\text{V}$, $I_C = 8\text{mA}$	5.2	5.8	6.4	V	
$V_{CE(sat)}$	Collector-Emitter saturation voltage	$T_j = 25^\circ\text{C}$, $V_{GE} = 15\text{V}$, $I_C = 200\text{A}$		2.0		V	
		$T_j = 125^\circ\text{C}$, $V_{GE} = 15\text{V}$, $I_C = 200\text{A}$		2.4		V	
R_{Gint}	Internal gate resistor	$T_j = 25^\circ\text{C}$		3.8		Ω	
C_{ies}	Input capacitance	$T_j = 25^\circ\text{C}$, $V_{CE} = 25\text{V}$, $V_{GE} = 0\text{V}$, $f = 1\text{MHz}$		18.0		nF	
C_{res}	Reverse transfer capacitance			0.60		nF	
t_{on}	Turn-on time	$T_j = 25^\circ\text{C}$, $V_{CC} = 900\text{V}$, $I_C = 200\text{A}$, $V_{GE} = \pm 15\text{V}$, $R_G = 6.8\Omega$, inductive load		310		ns	
t_r				98		ns	
t_{off}	Turn-off time			1008		ns	
t_f				202		ns	
E_{on}	Turn-on energy loss per pulse				78		mJ
E_{off}	Turn-off energy loss per pulse				63		mJ
I_{SC}	SC data	$t_{SC} \leq 10\mu\text{s}$, $V_{GE} = 15\text{V}$, $T_j = 125^\circ\text{C}$, $V_{CC} = 1000\text{V}$, $V_{CEM} \leq 1700\text{V}$		800		A	
t_{SC}	Short circuit withstandt time	$T_j = 125^\circ\text{C}$	10			μs	
V_F	Forward on voltage	$T_j = 25^\circ\text{C}$, $I_F = 200\text{A}$		1.80		V	
		$T_j = 125^\circ\text{C}$, $I_F = 200\text{A}$		1.90		V	
I_{RM}	Peak reverse recovery current	$I_F = 200\text{A}$, $-diF/dt = 3600\text{A}/\mu\text{s}$, $V_R = 900\text{V}$, $V_{GE} = -15\text{V}$, $T_j = 125^\circ\text{C}$		231		A	
Q_r	Recovered charge			85.4		μC	
E_{rec}	Reverse recovery energy			48		mJ	
$R_{th(j-c)}$	Thermal resistance (1 device)	IGBT			0.099	$^\circ\text{C}/\text{W}$	
		FWD			0.19	$^\circ\text{C}/\text{W}$	
$R_{th(c-f)}$	Contact thermal resistance (1 devide)	with thermal compound		0.035		$^\circ\text{C}/\text{W}$	
W_t	Weight				300	g	
Outline		454H3P					

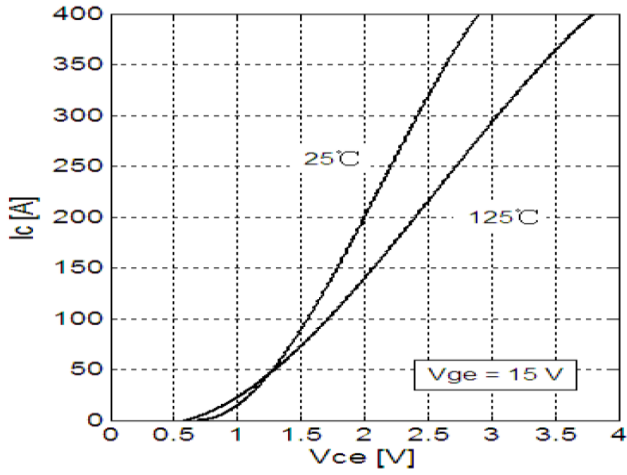


Fig 1. IGBT Typical Output Characteristics

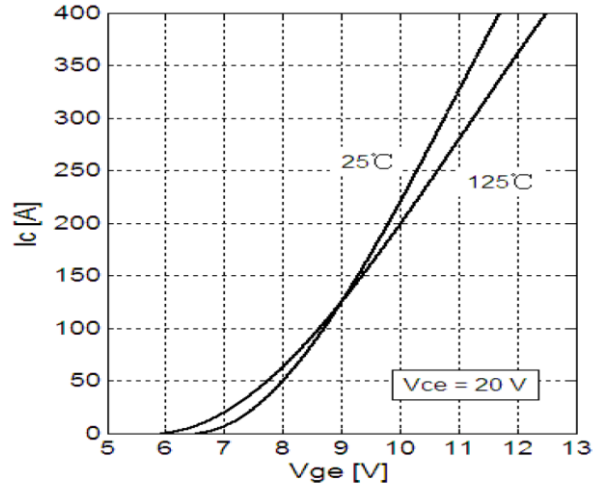


Fig 2. IGBT Typical Transfer Characteristics

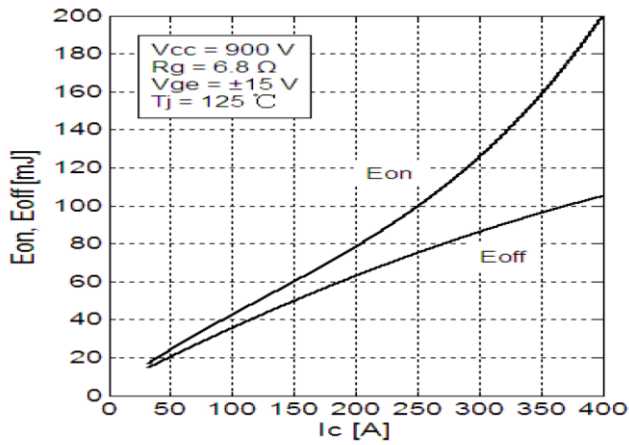


Fig 3. IGBT Switching Loss vs. Collector Current

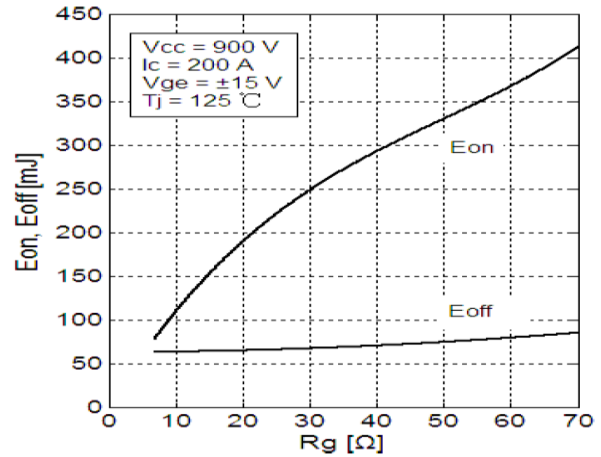


Fig 4. IGBT Switching Loss vs. Gate Resistor

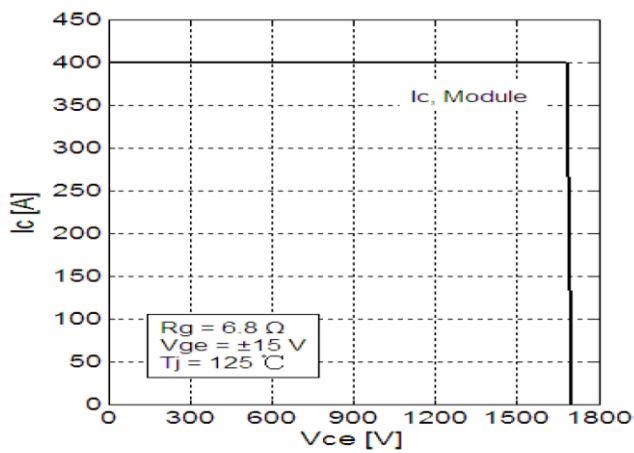


Fig 5. RBSOA

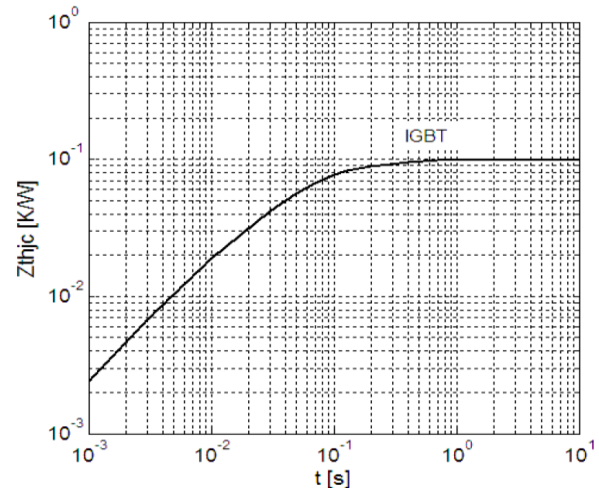


Fig 6. IGBT Transient Thermal Impedance

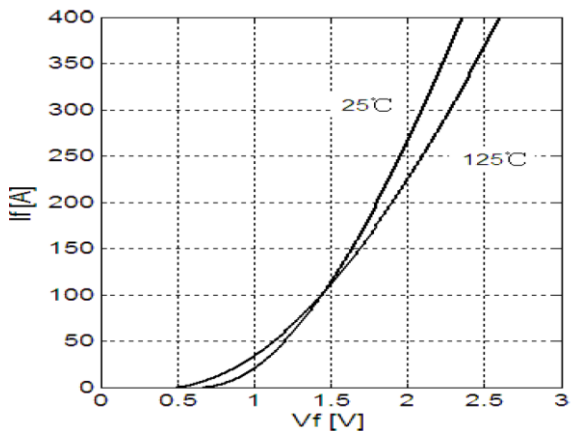


Fig 7. Forward Characteristics of Diode

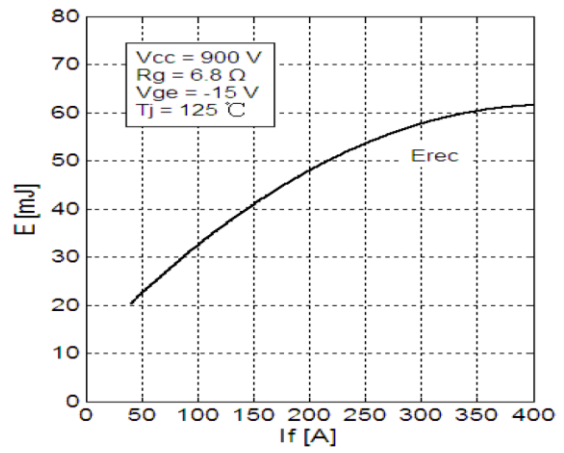


Fig 8. Diode Switching Loss vs. Collector Current

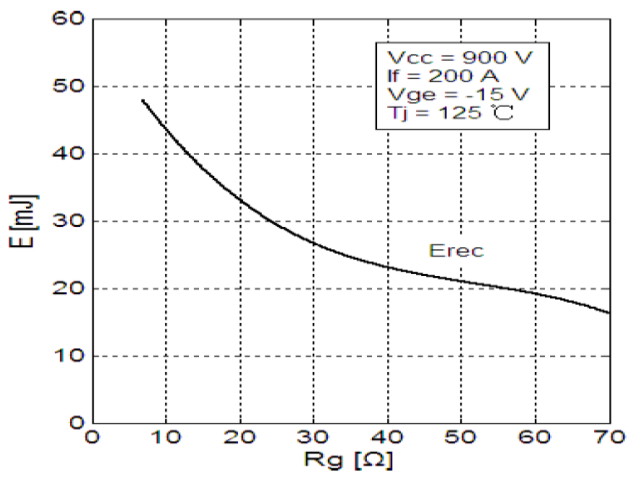


Fig9. Diode Switching Loss vs. Gate Resistor

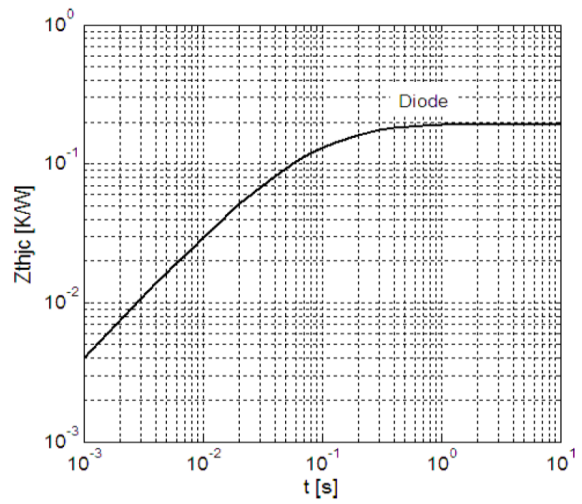
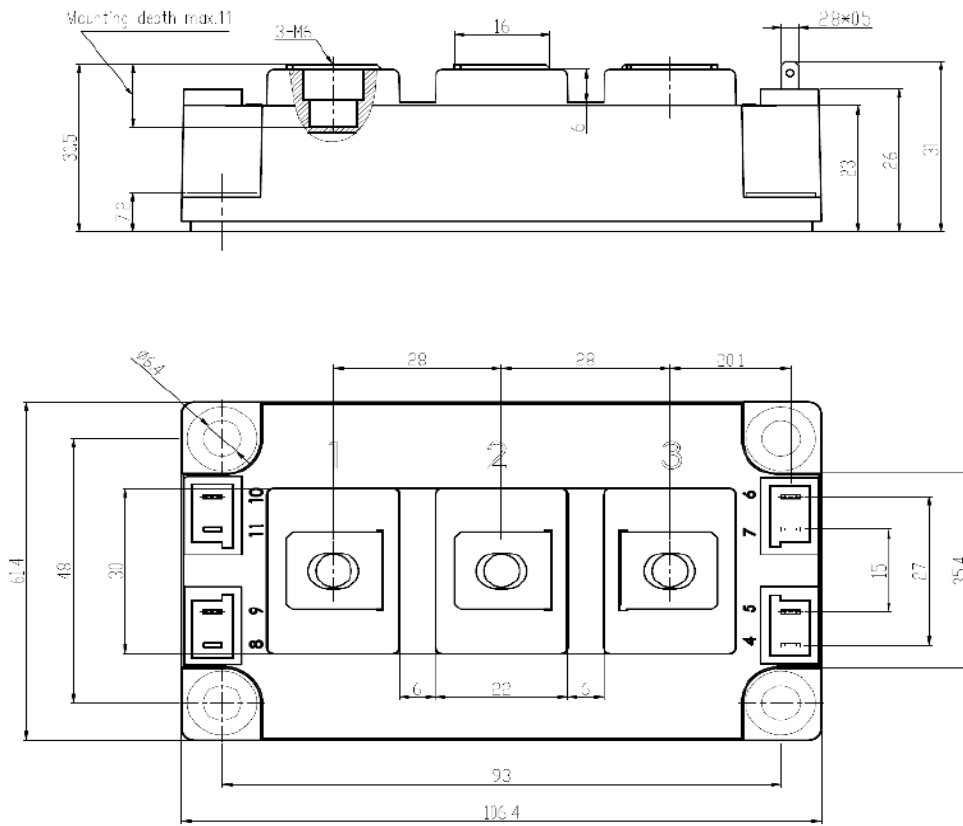


Fig 10. Diode Transient Thermal Impedance

Outline:

Outline:



(dimensions in mm)

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